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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/080,845	02/22/2002	David M. Braun	10020155-1	9676

7590 05/01/2006
AGILENT TECHNOLOGIES, INC.
Legal Department, DL429
Intellectual Property Administration
P.O. Box 7599
Loveland, CO 80537-0599

EXAMINER

PHILPOTT, JUSTIN M

ART UNIT	PAPER NUMBER
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2616

DATE MAILED: 05/01/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/080,845

Applicant(s)

BRAUN ET AL.

Examiner

Justin M. Philpott

Art Unit

2616

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 06 March 2006.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-15 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1 and 13 is/are rejected.
- 7) ☒ Claim(s) 2-12, 14 and 15 is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
- ☐ Certified copies of the priority documents have been received.
 - ☐ Certified copies of the priority documents have been received in Application No. _____.
 - ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- ☐ Notice of References Cited (PTO-892)
- ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____
- ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____
- ☐ Notice of Informal Patent Application (PTO-152)
- ☐ Other: _____

DETAILED ACTION

Response to Arguments

1. Applicant's arguments filed March 6, 2006 have been fully considered but they are not persuasive.

Specifically, applicant argues (at page 7) that Rabolt does not teach “applying [a] modulated signal to a wavelength meter”. In particular, applicant argues that “IR source 110” is not a modulated signal. However, Examiner has not relied upon “IR source 110” as being applicant’s claimed modulated signal. Rather, Examiner has referenced a passage of Rabolt which indicates that the IR source 110 is transmitted through sample 120 which modulates the signal before detector 160 picks up the signal (e.g., see col. 3, lines 53-65). It is this modulated signal of Rabolt that anticipates applicant’s claimed “modulated signal”. Accordingly, applicant’s argument is not persuasive.

Additionally, applicant argues (at page 8) that Rabolt does not provide a sum that represents the power of the modulated signal applied to a wavelength meter. However, as discussed in the previous office action, and repeated herein, Rabolt teaches summing a series of bin values within the frequency transformed interferogram over the designated bin range (e.g., see col. 3, lines 61-65 regarding recombined to result in an interference pattern) to provide a sum (e.g., see col. 4, line 1 regarding summation of all wavelengths) that represents the power of the modulated signal to a predetermined accuracy (e.g., see col. 3, lines 36-44 regarding spectral information, and see col. 5, line 42 wherein spectral information is indicated as a power spectrum). Accordingly, applicant’s argument is not persuasive.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

3. Claims 1 and 13 are rejected under 35 U.S.C. 102(e) as being anticipated by the prior art in U.S. Patent No. 6,784,428 to Rabolt et al.

Regarding claim 1, the prior art of Rabolt teaches a method for determining power of a modulated signal (e.g., see col. 3, line 45 – col. 4, line 19), comprising: applying the modulated signal (e.g., see col. 3, lines 53-59 regarding modulating) to a wavelength meter (e.g., see col. 3, line 45 regarding Michelson interferometer) to provide a frequency transformed interferogram (e.g., see col. 3, line 46 regarding interferogram) representing the modulated signal by a plurality of consecutive frequency bins (e.g., see col. 3, line 58 regarding individual frequencies), each frequency bin (e.g., individual frequency) in the plurality of frequency bins having a corresponding bin value (e.g., frequency or a corresponding wavelength); designating a bin range (e.g., frequency range or wavelength range according to path length difference) within the frequency transformed interferogram (e.g., see col. 3, lines 53-65 regarding path length difference); and summing a series of bin values within the frequency transformed interferogram over the designated bin range (e.g., see col. 3, lines 61-65 regarding recombined to result in an interference pattern) to provide a sum (e.g., see col. 4, line 1 regarding summation of all

Art Unit: 2616

wavelengths) that represents the power of the modulated signal to a predetermined accuracy (e.g., see col. 3, lines 36-44 regarding spectral information, and see col. 5, line 42 wherein spectral information is indicated as a power spectrum).

Regarding claim 13, the prior art of Rabolt teaches designating a bin range within the frequency transformed interferogram is performed automatically based on attributes of the frequency transformed interferogram (e.g., see col. 3, lines 36-65 regarding obtaining a path length difference to produce the interferogram).

Allowable Subject Matter

4. Claims 2-12, 14 and 15 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

5. The following is a statement of reasons for the indication of allowable subject matter:

Claim 2 recites the designating of the bin range in accordance with claim 1 which further comprises mapping a series of signal characteristics to a corresponding series of bin spans and enabling a selection of one signal characteristic from the series of signal characteristics, wherein in response to selection of the one signal characteristic from the series of signal characteristics establishing the designated bin range as having a bin span that corresponds to the selected one signal characteristic defined by the mapping of the series of signal characteristics to the corresponding series of bin spans, and being centered about a center bin within the frequency transformed interferogram; wherein such steps were not found in a search of related prior art;

Art Unit: 2616

and claims 3-12 depend upon claim 2 and therefore comprise allowable subject matter for the same reason discussed above regarding claim 2.

Claims 14 and 15 recite the designating of the bin range in accordance with claim 1 which further comprises accessing bin values corresponding to multiple frequency bins within the frequency transformed interferogram and based on the accessed bin values establishing the bin ranges to be centered about a center bin within the frequency transformed interferogram and to have a bin span within the frequency transformed interferogram that includes a predesignated number of sidebands, or spans a sufficient number of frequency bins, on each side of the center bin, wherein the predesignated number of sidebands represent modulation of the modulated signal, or wherein any bin span wider than the bin span has bin values that do not exceed a designated threshold of the frequency transformed interferogram; wherein such methods were not found in a search of related prior art.

Conclusion

6. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

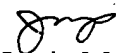
Art Unit: 2616

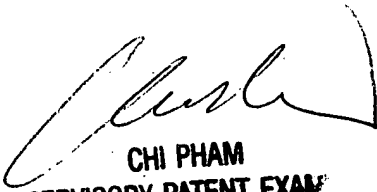
however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Justin M. Philpott whose telephone number is 571.272.3162. The examiner can normally be reached on M-F, 9:00am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Chi Pham can be reached on 571.272.3179. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).


Justin M Philpott


CHI PHAM
SUPERVISORY PATENT EXAMINER
4/26/06